Form PTO 1449		U.S. DEPARTMENT OF COMMERCE		ATTY DOCKET NO.		SERIAL NO.	
(Modified)		PATENT AND TRAD	EMARK OFFICE	289122US2X PCT		10/574,548	
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Motoyasu TANAKA, et al.			
				FILING DATE		GROUP	
				February 21, 2007		2153	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	6,073,147	06/06/2000	Allen M. CHAN, et.al.			
	AB	2003/0154446 A1	08/14/2003	Nicholas Robert CONSTANT, et.al.			
	AC	2002/0090935 A1	07/11/2002	Takeshi ANZAI			
	AD	2004/0193638 A1	09/30/2004	Shigeki TANIGUCHI, et.al.			
	AE	2002/0010725 A1	01/24/2002	Lawrence Wai Ming MO			
	AF	2001/0034783 A1	10/25/2001	Yoshimasa KITAMURA			
	AG						
	АН						
	Al						
-	AJ						
	AK						
	AL						<u> </u>
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
	AO	1 111 883 A2	06/27/2001	Europe			
	AP	03/050645 A2	06/19/2003	WIPO	·		
	AQ	02/100121 A2	12/12/2002	WIPO			
	AR	03/042818 A1	05/22/2003	WIPO (With English Abstract and corresponding US 2004/0193638 A1)			x
	AS	2 348 082 A	09/20/2000	United Kingdom			
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ			Additional References sheet(s) attached			
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in							
conformance and not considered. Include copy of this form with next communication to applicant.							